Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/725,772	SERRA, LUIS	
Examiner	Art Unit	
Phu K Nauven	2628	

SEARCHED				
Class	Subclass	Date	Examiner	
Update	search	5/28/2007	PN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Update WEST, IEEE, ACM searches	5/28/2007	PN
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